Specifications

Products Name	Thick Film Low Ohmic Chip Resistor
Product Series	LRT6432WR***F
Classification	Generic Specification





SMT Metal Thick Film Chip Resistor Specification

Scope

This specification applies to SMT Metal Thick Film Low Ohmic Chip Resistor

Part Number

LRT	6432	W	R***		*
Part	Size	Termination	Resistance		Tolerance
Series		W: With Side		4digits for below 100mΩ	F: ±1%
	2512	Termination	E24 series	R047: 47mΩ	G: ±2%
				3digits for 100m ohm and above	J: ±5%
				R10: 100mΩ, 1R0: 1Ω	
			E96 series	4digits R499: 499mΩ	

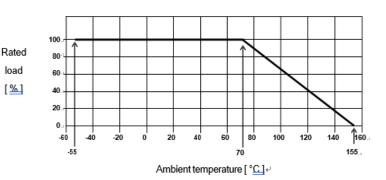
Electrical Specification

Size	Rated power	Range of resistance	Tolerance (Nominal Resistance Series)	TCR
6432	1W	100m~10Ω	F: ±1.0%(E96, E24) G: ±2.0%(E24) J: ±5.0%(E24)	±100ppm/deg. C
0432	IVV	47m~91mΩ	G: ±2.0%(E24) J: ±5.0% (E24)	±350ppm/deg. C

<Ratings>

Parameter	Specification
Rated Ambient	170 deg. C. Defer to Dereting ourse Figure 1
temperature	+70 deg. C Refer to Derating curve, Figure-1
Rated Operating	
Temperature	-55~+155 deg. C
Range	
Rated Voltage	√Power x Resistance (V)

Figure-1



Structure/Dimensions/Marking

<Structure>

This part has a structure that metal glazed resistor is formed on ceramic substrate with the termination layers interconnected, and the passivation coated (See figure-2) under construction and composition as shown in the chart in the below (See Figure-3).

Figure-2

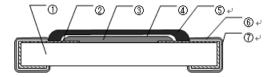


Figure-3

Symbol	Construction	Composition
1)	Substrate	Al2O3(96%)
2	Inner Electrode	Ag-Pd Thick Film (Side face: Ag paste thick film)
3	Resistor	Ag-Pd Thick Film
4	Inner Protection coating	Glass passivation
5	Outer Protection coating	Epoxy Thick Film
6	2 nd Side Electrode	Ni plating
7	3 rd Side Electrode	Sn plating

<Dimension>

Figure-4

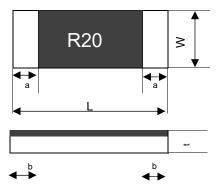


Figure-5

Dimension (mm)				
L	W	a	b	t
6.30 ± 0.20	3.20 ± 0.20	0.70 ± 0.20	0.70 ± 0.20	0.60 ± 0.10

<Marking>

E24 series: below 100m ohm, 4 digits (Ex.) 47m ohm turns to be R047

100m ohm and above, 3 digits (Ex.) 470m ohm turns to be R47

E96 series: 4digits (Ex.)499m ohm turns to be R499

Reliability Characteristics

Figure-6

Item	Condition		Specification	
Short Time	Loading power = 2.5 times x the rated voltage		12.00/	
Overload	Loading time = 5sec.		±2.0%	
High Temp.	Thermostatic Chamber = 155±3 deg. C		14.00/	
Exposure	Retention time = 1000 $h \pm {}^{48}_{0}$ Hrs.		±1.0%	
Low Temp.	Thermostatic Chamber=-55±3 deg. C		±1.0%	
Exposure	Retention time = 1000 h $\pm {}^{48}_{0}$ hrs.		±1.0%	
	Thermostat Chamber=40°C±2 deg. C 90~9	5%RH		
Temp./Humidity	Loading voltage = Rated voltage		±3.0%	
Biased Test	A cycle=90min. on \sim 30mi. off		13.070	
	Retention time cycled = $1000 \mathrm{h} \pm_0^{48}$ hrs.			
	A series of dwell time at each stage in the			
	below cycles;			
Thermal Cycle	Stage $1 = -55$ °C±3 deg. C for 30min.	100	±1.0%	
Thermal Cycle	Stage 2=RT within 3 min.	cycles	11.070	
	Stage 3=+155±3 deg. C for 30min.			
	Stage4 = RT within 3 min.			
	Thermostat Chamber = 70±3 deg. C		±3.0%	
Load Life	Loading voltage = Rated voltage			
Load Liic	Retention time=90min. on~30min.off			
	1000 h ± ⁴⁸ ₀ hrs.			
	Solder Temp. = 245±5 deg. C		Nove coldened coveres	
Soldorobility	Soaking time = 3±0.5sec.		New soldered coverage	
Solderability	Pre-conditioning = immersing in flux for 1 \sim 2s	ec.	takes up 95% of terminations	
	Flux=IPA solution with 25% weight ratio of ros	sin solvent	terrimations	
Soldering Heat	Solder Temp. = 260±5 deg. C (Molten solder)		No solder leach	
Resistance	Soaking time = 10±1sec.		observed	
	A distance between two supporting points: 90mm			
Board Flex	Flex depth: 1mm		±1.0%	
Board Flex	Board : Glass Epoxy t =1.6mm			
	Retention time = 10±1sec.			
Insulation	Applied voltage:DC100V±15V under the set	tup shown		
	in the below for 1min and measure resistance	e .	1,000M Ω or over	
	(from termination to substrate)			
		_		

Dialastria		No damage by flash-
Dielectric	With 400V to be applied under the setup shown in the	over, burnout and
withstanding	below for 60±5s.	dielectric breakdown.
		leak current: ≦2mA,

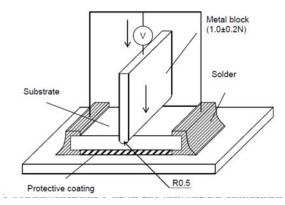


Figure-7 Measurement Setup for insulation resistance/dielectric withstanding voltage

<u>Packaging</u>

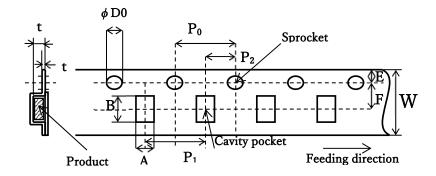


Figure-8 Embossed Plastic Taping

Denote	Dimension
W	12.00 ± 0.20
P0	4.00 ± 0.10
P1	4.00 ± 0.10
P2	2.00 ± 0.10
A	3.40 ± 0.20
В	6.60 ± 0.20
D0	1.55 ± 0.10
F	5.50 ± 0.10
Е	1.75 ± 0.10
t 1	0.25 ± 0.10
t 2	1.0 ± 0.10

Figure-9 Finish Specification of Leading end

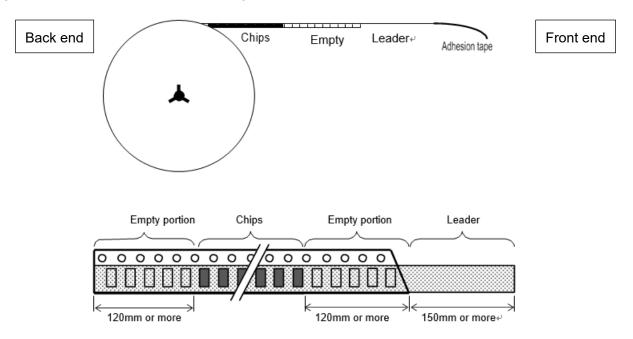
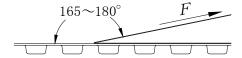
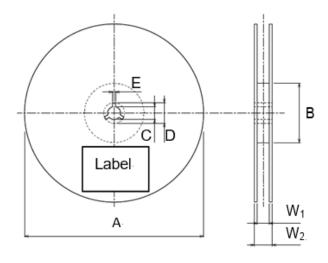


Figure -10 Cover Tape Peel-off Strength

F = Peel-off Strength : 0.1-1.0 N (10-100 gf)



Figigure-11 Reel Configuration(Plastic Reel)

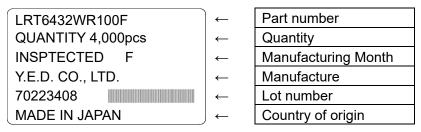


Material: Plastic

6332 Denote SPQ 4000 180 ± 3.0 ϕA 60.0 ± 1.0 ϕ B ϕC 13.0 ± 0.2 ϕ D 21.0 ± 0.8 Е 2.0 ± 0.5 W1 13.0 ± 0.3 W2 15.4 ± 0.1

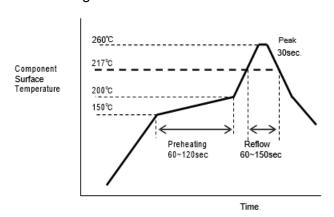
(Unit: mm)

Figure-12 Labelling



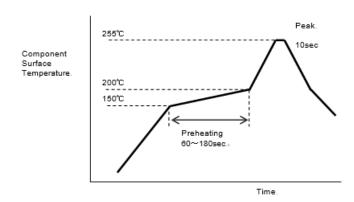
Soldering Temperature Profile

Figure-13 Reflow profile (max. 3 cvcles)



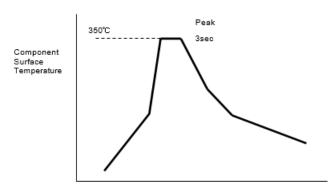
	Lead-free solder Sn-3.0Ag-0.5Cu
Preheat.	150~200°C, 60~120sec.
Reflow	Min. 217°C, 60~150sec
Peak.	255~260°C, 30sec Max.

Figure-14 Flow profile (max. 3 cycless)



	Lead-free solder
	Sn-3.0Ag-0.5Cu
Preheat	150~200deg.C, 60~180sec.
Peak.	Max.255°C. 10sec or less

Figure-15 Soldering iron condition



	Lead-free solder Sn-3.0Ag-0.5Cu.
Soldering iron	Max.350deg. 3sec

Time

<u>Storage</u>

The products should be kept packed and stored at temperature of 15~35°C and a humidity 25~85%RH. The products should not be left in the place affected by direct sunlight and harmful gas (chlorine, sulfur, etc.). Warranty period: 1 year after shipping date.

***** E&OE *****